

Innovations in Photonic Analog-to-Digital Converters: Advancements and Future Prospects

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Abstract— This paper discusses photonic analog-to-digital converters (ADCs) which can overcome the limitations of traditional electronic ADCs in high-speed, high-resolution applications. As data rates increase in telecommunications, radar systems, and scientific instrumentation, the need for faster ADCs grows. Photonic ADCs leverage unique properties of light to achieve higher sampling rates and bandwidths than electronic systems. Various architectures like time-stretch, photonic time-interleaved, and optical-hybrid ADCs are introduced. We present a comprehensive analysis of the advantages of photonic ADCs, detailing their advantages like multi-gigahertz sampling rates, low jitter, and improved linearity. Challenges including power consumption, integration with CMOS electronics, and cost are also discussed. Experimental demonstrations and performance benchmarks are reviewed and future research directions and potential impact of photonic ADCs on next-gen wireless communications and high-performance instrumentation are also reviewed.

Keywords— Analog to Digital converters; ADCs; Photonics; optoelectronics.

I. INTRODUCTION

The ever-increasing demand for higher data rates and bandwidth in modern technologies involving telecommunications, radar systems, and scientific instrumentation has pushed traditional electronic analog-to-digital converters (ADCs) to their fundamental limits. As we approach the physical boundaries of electronic systems, a fundamentally different approach or a paradigm shift is necessary to continue advancing in the field of high-speed, high-resolution data conversion. Photonic ADCs have emerged as a promising solution, exploiting the unique properties of light to achieve sampling rates and bandwidths far beyond what is possible with purely electronic systems.

This paper presents a comprehensive review of the rapidly evolving field of photonic ADCs, exploring their potential to revolutionize high-speed data conversion technologies. We begin by examining the fundamental principles of ADCs in general and the current state-of-the-art technology in purely electronic ADC technology, highlighting the limitations that have inspired research into photonic technology. The concept of photonic ADCs is then introduced, along with an in-depth discussion of various architectures that have been proposed and demonstrated in recent years. We explore how these components are integrated to create systems capable of overcoming the speed and resolution trade-offs and limitations of traditional ADCs. The paper delves into the significant advantages offered by photonic ADCs, such as sampling rates on the scale of gigahertz, reduced jitter, and improved linearity, while also addressing the challenges that must be overcome for widespread adoption of Photonic ADCs. Recent experimental demonstrations are reviewed, providing an image of the current state of the technology and benchmarking performance against electronic counterparts.

The potential applications of photonic ADCs are explored. Finally, we discuss future research directions and the potential impact of photonic ADCs on the broader field of data conversion. This paper aims to provide researchers, engineers, and decision-makers with a comprehensive understanding of photonic ADC technology, its current capabilities, and its future prospects in shaping the landscape of high-speed digital systems.

II. TRADITIONAL ANALOG TO DIGITAL CONVERTERS(ADCs)

Analog to digital converters are electronic devices that transform analog signals into a digital stream of bits. First, the analog signal, which varies continuously over time, is sampled at discrete time intervals at the desired sampling rate which must be more than the Nyquist rate. The signal is then quantized by mapping the samples to a discrete and finite set of amplitude levels, each corresponding to a unique binary number in a process called encoding which will be examined next. The number of quantization levels is determined by the ADC's resolution. More bits imply more accurately represented signals when converted to digital and thus less distortion and noise. The next step is encoding, where each quantized level is assigned a binary code, this binary code is the digital representation of the analog input at that particular instant. The amplitude is divided into 2^N levels if N bits are used to quantize the signal. As discussed previously, more bits imply more accuracy and less distortion. Finally, the digital output can be used for further processing, storage, or display. This process of analog to digital conversion comes with trade-offs across certain parameters, like speed, resolution and SNR.

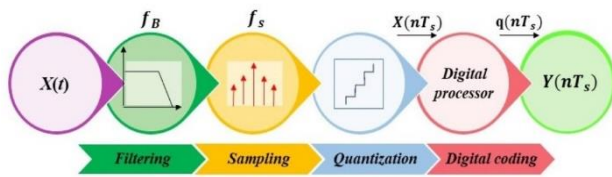


Fig. 1. Block diagram of a photonic analog-to-digital converter (ADC) process flow, illustrating the key stages from analog input to digital output including filtering, sampling, quantization, and digital coding.

III. ENCODING TECHNIQUES

The process of assigning a binary number to an analog signal at every level of quantization can be a tedious task, especially if the signal is a random process and jumps across values too quickly like in the case of audio recordings. If levels were to be followed in an ascending order, the computationally intensive process of encoding at the next instance would slow down the conversion process. Thus time efficient coding schemes as below are used widely in ADCs.

Gray Code:

This type of coding is where in an N bit string, the subsequent string differs from the previous by 1 flipped bit. This ensures speedy assignment of a binary number to the analog signal at that instant by flipping 1 bit at a time for the next quantized level. The encodings will not be in ascending order but will assign the corresponding discretized levels with unique binary numbers. This coding method helps reduce errors as well. In high-speed ADCs, it's used to encode the output of a digital signal processor (DSP) or as an intermediary step between stages of a multi-bit ADC, ensuring only one bit changes at a time and reducing glitch susceptibility.

Thermometer Code:

This type of coding can store N values in N bits, it is computationally efficient as in a string of N bits we flip bits 1 by 1 from LSB to MSB and the values will be in ascending order. While the drawback is that it requires N bits to represent N values and not $\log_2 N$ bits, it offers the advantage of speed. Flash ADCs innately have the binary conversion in thermometer code, which can later be converted to normal binary coding if needed.

Circular Rotation:

A string of bits is shifted circularly, in the manner of the overflowing bit coming back to the first bit. These are mostly used in signal processing related applications of ADCs. This again allows for speed using the mechanism of a shift register alone, instead of needing compute elements. Just like the thermometer code this can also represent only N values at most for a string of N bits.

IV. TYPES OF TRADITIONAL ADCS

Flash ADC: Flash ADCs are known for their high-speed operations, they operate with N comparators in parallel to produce an output of N bits. Each comparator generates a high output (1) when a specific voltage threshold is exceeded. The comparators function similarly to a priority encoder, producing outputs in thermometer code format. This bears a disadvantage of a large die size for accommodating a large number of comparators in case of large amount data but provides the best possible speed.

Pipeline ADC: Pipeline ADC overcomes the issue of die area at the cost of latency, these make use of segmented data accessing the ADC elements like comparators in the case of flash ADCs at intervals. This makes a good trade-off between speed and die area. Multiple stages of lower-resolution ADCs are used to achieve high-speed and high-resolution conversion. Each stage processes the residual error from the previous stage, improving accuracy. This ADC is widely used in high-speed communication systems and high-definition video recording.

Successive Approximation Register (SAR) ADC: Speed and accuracy is balanced by successively changing its approximation of the input voltage. It uses a binary search algorithm and also has a DAC whose output is adjusted and compared with the input signal until the digital output converges to the analog input.

Time-Interleaved ADC: This technique involves multiple ADCs operating in parallel with shifted sampling times to increase overall conversion speed. Each ADC samples the input signal at different times, and the outputs are combined to form a high-speed digital output, like 4 different low resolution ADCs combining to form a high resolution ADC.

V. RESOLUTION SPEED TRADE-OFFS

Resolution refers to the number of bits an ADC uses to represent the analog signal. Higher resolution means the ADC can detect smaller differences in the input signal, resulting in a more accurate digital representation. However, achieving higher resolution requires more bits, leading to slower processing and large data outputs or larger die areas. Speed on the other hand refers to how quickly the ADC can sample and convert the analog signal into digital data. High-speed ADCs can capture rapid changes in the input signal by minimizing processing time and allowing for the whole converter to be ready for the next sample, making them ideal for applications requiring real-time data processing. But hasty methods of conversion lead to compromise in accuracy by reducing the number of bits used in digital representation or making rough approximations for the sake of speed which may distort the signal when it is reconverted or worse, the errors may get amplified during processing. This poses to us the situation having to compromise either the speed for high accuracy applications or having to compromise on accuracy for speed flash ADCs may be a good solution but it also

comes with the cost of having to compromise on die area. Photonic ADCs have an edge over purely electronic ADCs because of the natural speed at which they operate i.e. light travels much faster in most media than current does in wires and the processing used, mostly interferometers operate as quick as opposed to compute elements in an electronic circuit.

VI. PHOTONIC ADCS

Photonic analog-to-digital converters (ADCs) leverage the unique properties of light to enable high-speed signal processing to overcome the limitations of traditional electronic ADCs. The core principle of photonic ADCs is to perform critical ADC operations like sampling and quantization in the optical domain first, then convert the signal to the electrical domain for further processing. This simple technique allows for ultra-high sampling rates, enhanced bandwidth, and reduced electromagnetic interference. In comparison to electronic ADCs, photonic ADCs can potentially reach sampling rates in the terahertz region. Photonic ADC's furthermore have ultra-low jitter sampling, wide bandwidth, low noise and improved linearity compared to the electronic ADC's. This enhanced linearity and dynamic range are made possible by the use of optical components, which makes photonic ADCs ideal for application in high-speed instrumentation, radar systems, and telecommunications.

By utilizing the properties of parallelism of optical systems, these ADCs allow for the processing of several channels simultaneously, increasing the overall throughput. One major benefit is that photonic ADCs can handle complicated, multi-dimensional data streams with extremely high levels of efficiency owing to their parallel processing capability. As research in this field continues to advance, photonic ADCs are anticipated to become more and more important in enabling next-generation high-speed communication systems. They hold great promise for upcoming 6G wireless networks, where it is critical to handle large volumes of data quickly. Photonic ADCs have the potential to significantly increase data transmission speeds in the field of fiber-optic communications, allowing for the possibility of long-distance terabit-per-second lines.

VII. WORKING OF PHOTONIC ADCS

A photonic ADC works by using a sequence of key stages that are integral to its high-speed signal conversion. It starts with generating optical signals, typically through a mode-locked laser that produces a stream of very short, precise optical pulses. These pulses are perfect for capturing fast-changing signals. The analog signal is then encoded onto these pulses via an electro-optic modulator, converting the variations in the electrical signal into corresponding changes in the optical signal. The optical pulses, due to their short length, allow sampling at extremely high rates, often in the

tens to hundreds of gigahertz range. Once the sampling is done, the optical signal is turned back into an electrical one by photodetectors, which retain the essential information from the original signal. The electrical signal is then passed to a conventional ADC, which converts it into digital form by assigning discrete values to the continuous signal. Finally, digital signal processing (DSP) is applied to clean up the signal, reduce noise, correct any errors, and rebuild a digital version of the analog signal. This approach enables photonic ADCs to offer much faster sampling speeds and greater bandwidth than traditional electronic ADCs.

VIII. PHOTONIC ADCS ARCHITECTURE

Several architectures have been proposed and demonstrated for photonic ADCs, each with its own strengths and challenges. The main architectures are:

Photonic Time-Stretch ADC: The photonic time-stretch ADC is a promising architecture for achieving ultra-high sampling rates. This process begins with the modulation of the analog signal onto an optical pulse train, then the modulated optical signal is sent through a dispersive medium, such as a fiber optic cable, where the different frequency components of the signal are temporally separated. This stretching effect allows the high-speed photodetector to sample the signal at a lower effective speed while maintaining high resolution.

Photonic Time-Interleaved ADC: The photonic time-interleaved ADC architecture employs multiple optical paths to achieve high sampling rates. In this architecture, several parallel photonic channels operate simultaneously, each sampling the analog signal at slightly staggered intervals. By combining the outputs of these parallel paths, the system effectively increases the overall sampling rate beyond what a single channel could achieve. This architecture typically utilizes multiple mode-locked lasers and corresponding photodetectors to create a synchronized multi-channel system.

Optical Hybrid ADC: The optical-hybrid ADC combines both optical and electronic processing techniques to enhance performance. In this architecture, the analog signal is first converted into the optical domain, similar to other photonic ADCs, and then undergoes processing using both optical and electronic components. After optical processing, the modulated signal is detected and converted into the electrical domain, where it is subsequently digitized by an electronic ADC. This hybrid approach allows the system to leverage the benefits of both optical processing (such as high bandwidth) and electronic processing (such as advanced DSP algorithms), resulting in improved performance metrics.

IX. ADVANTAGES

Photonic ADCs bring a lot of advantages compared to presently used electronic ADCs. One major advantage is their ability to handle high sampling rates. This is essential for

capturing ultra-wideband signals in areas like radar and future wireless communication systems. These ADCs are also excellent in reducing timing jitter, helping to improve the SNR at higher frequencies, which leads to more accurate data conversion. The wide bandwidth capability of photonic ADCs is another advantage as it allows multiple signal bands or channels to be digitized at the same time, making it ideal for creating SDRs with vast frequency ranges. Additionally, optical components have better linearity than electronic components, which means they can handle signals with high peak-to-average power ratios more accurately. Together, these benefits suggest that photonic ADCs are set to revolutionize high-speed, high-precision signal conversion in a wide range of fields.

X. CHALLENGES AND LIMITATIONS

While photonic ADCs offer substantial benefits, several challenges must be addressed for widespread adoption. One key issue is their high power consumption, especially due to the energy demands of laser sources and active optical components like modulators and amplifiers. Additionally, photonic ADC systems are often more complex and costlier than electronic counterparts, with expensive components and intricate assembly requirements. A challenge also lies in the limited bandwidth of the electronic backend, which can struggle to keep pace with the high-speed optical front end. While photonic systems can offer improved linearity in some respects, they also introduce new sources of nonlinearity and noise like nonlinear effects in optical fibers and waveguides, intensity noise from laser sources and thermal noise in photodetectors. Furthermore, the lack of standardization in this relatively young field adds to the difficulty, affecting integration with existing systems. Successfully overcoming these challenges is crucial for realizing the full potential of photonic ADCs in practical applications. Ongoing research and development efforts are focused on overcoming these limitations, paving the way for next-generation high-performance ADC systems that can fully leverage the advantages of photonic technologies.

XI. EXPERIMENTAL DEMONSTRATIONS

Upon reviewing paper [1] which demonstrates the working of a discrete-component Photonic ADC, we gather the following data.

- Sampling Rate:
 - Value: 2.1 GSa/s (giga-samples per second), achieved by interleaving two 1.05 GSa/s channels.
- Test Signal Frequency:
 - Value: 41 GHz.
- Mode-Locked Laser Jitter:
 - Value: Integrated jitter of 13.8 fs (femtoseconds) within a [10 kHz – 10 MHz] frequency interval, and 10.8 fs within a [100 kHz – 10 MHz] interval.
- Effective Number of Bits (ENOB):

- Value: 7.0 ENOB.

- Spurious-Free Dynamic Range (SFDR):
 - Value: 52 dBc (decibels relative to carrier).

On analysis of the above data, we can conclude that a value of 2.1GSa/s allows for the ultra-high-speed sampling for high-frequency signals, which is an advantage over traditional electronic ADCs. A test signal frequency of 41GHz of the discrete-component Photonic ADC demonstrates it's ability to handle ultra-high frequency signals, significantly higher than what electronic ADCs typically manage. The extremely low timing jitter shows the precision of the photonic system. ENOB is a key measure of an ADC's resolution and performance and a value of 7.0 indicates the system's high accuracy when sampling at high frequencies. Furthermore, a 52 dBc SFDR shows the system's efficiency in minimizing distortions and spurious signals.

Table I: Comparison with Electronic ADCs

ADC Type	Sampling Rate	ENOB (at Nyquist)	Power Consumption
State-of-the-art Electronic	10 GS/s	5-6 bits	1-10 W
Photonic Time-Stretch	100 GS/s	3-5 bits	10-100 W
Photonic Time-Interleaved	10 GS/s	6-7 bits	5-50 W
Integrated Photonic	4-100 GS/s	3-6 bits	1-10 W

Note: Values are approximate and represent typical ranges based on recent publications.

XII. SUGGESTIONS TO IMPROVE THE CURRENT STATE OF PHOTONIC ADCS

To improve the current state of photonic ADCs, several key areas can be addressed. One solution is the development of more efficient, low-power laser sources, which can significantly reduce the overall power consumption of the system. Passive mode-locking techniques for integrated lasers offer a path to create compact, energy-efficient light sources while maintaining high performance. Further advances in low-power modulator technologies will help minimize power requirements during optical-to-electronic signal conversion. Additionally, improved thermal management strategies are critical for optimizing the efficiency and reliability of photonic integrated circuits (PICs), especially as device densities increase. Addressing the limited electronic backend bandwidth requires the development of faster electronic ADCs and digital signal processors capable of handling the high-speed data output of photonic systems. Exploring analog optical computing techniques could also reduce the reliance on electronic

processing, enabling faster data conversion and processing. Advances in high-speed data interfaces and interconnects are essential to bridge the performance gap between photonic and electronic components. To tackle nonlinearities and noise, linearization techniques for optical components, such as modulators and amplifiers, are vital. The use of low-noise laser sources and photodetectors further improves signal quality, while digital post-processing techniques can be implemented to compensate for any residual nonlinearities, ensuring higher accuracy and resolution in the ADCs. These approaches collectively hold the potential to significantly enhance the performance of photonic ADCs in future systems.

XIII. FUTURE RESEARCH DIRECTIONS

As we have seen, a significant challenge remains to be overcome in chip photonics. This is a direction in which progress is definitely needed if we are to consider using photonic technology in most devices. We must look into methods of integration that go hand in hand, as much as possible with what exists today. Technologies like Silicon on Insulator (SOI) has been shown to have high compatibility with CMOS technology, there are other components like InP which are good photonic media but have less compatibility in comparison to others. Materials of the category Van der Waals have also been proposed as a good solution to on chip photonics [3]. These materials can be used to make on chip photodetectors, waveguides and light sources.

There are various types of noise in photonic circuits including photon noise, thermal noise, absorption and scattering and crosstalk and interference. These arise due to the inherent nature of light and its propagation and pose a significant threat to signal integrity in photonic systems [4][5]. For widespread use, photonic devices must be able to work on the available power supply of most devices without significantly altering the framework for the electronic devices. Low power optoelectronics requires careful research into material which are able to inherently manage photoelectric processes. Various technologies like Ge or Si-Ge quantum wells, focuses on exploiting the low energy difference between the direct and indirect band gaps allowing for photonic operations while consuming less energy [2].

XIV. CONCLUSION

Photonic ADCs represent a promising frontier in high-speed, high-resolution signal digitization. By exploiting the advantageous and unique properties of light, photonic ADCs offer the potential to overcome fundamental limitations of purely electronic ADCs, particularly in terms of sampling rate and bandwidth. Throughout this paper, we have explored the fundamental concepts, key architectures, enabling technologies and current state-of-the-art technology in photonic ADC research. The advantages of photonic ADCs, including ultra-high sampling rates, low jitter, and

wide bandwidth, enable them to further technology in the direction of telecommunications, advanced radar systems, etc.

Experimental demonstrations have shown impressive results, with sampling rates reaching 100 GS/s and analog input bandwidths exceeding 40 GHz. These achievements highlight the potential of photonic ADCs to enable direct digitization of high-frequency signals and ultra-wideband communications channels.

However, significant challenges remain. Issues such as power consumption, cost, integration complexity and limited dynamic range must be addressed for photonic ADCs to be able to look forward to adoption. The future research directions outlined in this paper provide a roadmap for tackling these challenges and further advancing the field.

As photonic integration technologies mature and novel architectures are developed, we can expect to see photonic ADCs playing an increasingly important role in high-performance signal processing systems. The convergence of photonics and electronics in integrated ADC solutions holds the promise for creating compact, efficient, and high-performance data conversion systems.

The field of photonic ADCs is rapidly evolving, with new breakthroughs and demonstrations regularly pushing the boundaries of what's possible in analog-to-digital conversion. As research progresses, photonic ADCs have the potential to enable new capabilities in areas such as terahertz communications, high-resolution radar imaging, and real-time monitoring of ultra-fast phenomena.

In conclusion, while challenges remain, the future of photonic ADCs appears bright. Continued research and development in this field are likely to yield transformative advances in high-speed signal processing, opening up new frontiers in communications, sensing, and scientific discovery. As we look to the future, photonic ADCs stand poised to play a crucial role in shaping the next generation of digital systems, enabling us to capture and process information from our world with unprecedented speed and precision.

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